

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/533,375	MENDELS, DAVID A.	
		Examiner	Art Unit	Page 1 of 4
		DANIEL WALSH	2887	

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<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/533,375	MENDELS, DAVID A.	
		Examiner	Art Unit	Page 3 of 4
		DANIEL WALSH	2887	

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		Examiner DANIEL WALSH	Art Unit 2887	Page 4 of 4

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